

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ANVEKAR ET AL.	
		09/452,802	Examiner	Art Unit
Emmanuel Bayard		2631	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,031,864	02-2000	Bauchot et al.	375/133
	B	US-6,424,820	07-2002	Burdick et al.	455/41.1
	C	US-6,295,310	09-2001	Yamauchi et al.	375/133
	D	US-5,394,433	02-1995	Bantz et al.	375/132
	E	US-5,276,686	01-1994	Ito, Koichi	370/330
	F	US-2001/0040878	11-2001	Schilling, Donald L.	370/329
	G	US-6,587,444	07-2003	Lenzo et al.	370/330
	H	US-5,781,582	07-1998	Sage et al.	375/134
	I	US-5,914,947	06-1999	Saito, Naritoshi	370/337
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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